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- 12 A Continuous On-State Current
- 100 A Surge-Current
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- Max I_{GT} of 20 mA



Pin 2 is in electrical contact with the mounting base.

MDC1ACA

absolute maximum ratings over operating case temperature (unless otherwise noted)

RATING			VALUE	UNIT	
	TIC126D		400		
Depetitive peak off state values	TIC126M	N	600	V	
Repetitive peak off-state voltage	TIC126S	V _{DRM}	700		
	TIC126N		800		
	TIC126D		400	V	
Depetitive people reverse veltage	TIC126M	N	600		
Repetitive peak reverse voltage	TIC126S	V _{RRM}	700		
	TIC126N		800		
Continuous on-state current at (or below) 70°C case temperature (see Note 1)			12	Α	
Average on-state current (180° conduction angle) at (or below) 70°C case temperature		I _{T(RMS)}	7.5	A	
(see Note 2)		I _{T(AV)}	7.5		
Surge on-state current at (or below) 25°C case temperature (see Note 3)		I _{TM}	100	Α	
Peak positive gate current (pulse width \leq 300 μ s)		I _{GM}	3	Α	
Peak gate power dissipation (pulse width \leq 300 μ s)		P _{GM}	5	W	
Average gate power dissipation (see Note 4)		P _{G(AV)}	1	W	
Operating case temperature range		T _C	-40 to +110	°C	
Storage temperature range			-40 to +125	°C	
Lead temperature 1.6 mm from case for 10 seconds		T _{stg} T _L	230	°C	

NOTES: 1. These values apply for continuous dc operation with resistive load. Above 70°C derate linearly to zero at 110°C.

2. This value may be applied continuously under single phase 50 Hz half-sine-wave operation with resistive load. Above 70°C derate linearly to zero at 110°C.

3. This value applies for one 50 Hz half-sine-wave when the device is operating at (or below) the rated value of peak reverse voltage and on-state current. Surge may be repeated after the device has returned to original thermal equilibrium.

4. This value applies for a maximum averaging time of 20 ms.



Information is current as of publication date. Products conform to specifications in accordance with the terms of Power Innovations standard warranty. Production processing does not necessarily include testing of all parameters.



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electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT	
I _{DRM}	Repetitive peak off-state current	V _D = rated V _{DRM}		$T_{C} = 110^{\circ}C$			2	mA
I _{RRM}	Repetitive peak reverse current	$V_{R} = rated V_{RRM}$	I _G = 0	T _C = 110°C			2	mA
I _{GT}	Gate trigger current	V _{AA} = 12 V	R _L = 100 Ω	t _{p(g)} ≥ 20 μs		8	20	mA
V _{GT}	Gate trigger voltage	V _{AA} = 12 V t _{p(g)} ≥ 20 µs	R _L = 100 Ω	$T_{\rm C} = -40^{\circ}{\rm C}$			2.5	
		$V_{AA} = 12 V$ $t_{p(g)} \ge 20 \ \mu s$	R _L = 100 Ω			0.8	1.5	v
		$V_{AA} = 12 V$ $t_{p(g)} \ge 20 \ \mu s$	R _L = 100 Ω	T _C = 110°C	0.2			
Ι _Η	Holding current	$V_{AA} = 12 V$ Initiating I _T = 100 mA		$T_C = -40^{\circ}C$			100	mA
		$V_{AA} = 12 V$ Initiating I _T = 100 mA					40	
V _T	On-state voltage	I _T = 12 A	(see Note 5)				1.4	V
dv/dt	Critical rate of rise of off-state voltage	$V_D = rated V_D$	I _G = 0	T _C = 110°C		400		V/µs

NOTE 5: This parameter must be measured using pulse techniques, t_p = 300 µs, duty cycle ≤ 2 %. Voltage sensing-contacts, separate from the current carrying contacts, are located within 3.2 mm from the device body.

thermal characteristics

PARAMETER		MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to case thermal resistance			2.4	°C/W
$R_{\theta JA}$	Junction to free air thermal resistance			62.5	°C/W

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THERMAL INFORMATION



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TYPICAL CHARACTERISTICS



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MECHANICAL DATA

TO-220

3-pin plastic flange-mount package

This single-in-line package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions. Leads require no additional cleaning or processing when used in soldered assembly.





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